Search Notes			

Application/Control No.	Applicant(s)/Patent u Reexamination	nder
10/662,383	SAFFORD ET AL.	
Examiner	Art Unit	
Cabriel Chu	2114	

SEARCHED				
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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714/30, m/ pd 20030313 -114/32 135 , 712/326,227	12/23	nc
7/2/206 7/2/209 micro, macro, test	12/23	 て(
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